Form PTO-1449 Equivalent U.S. Department of Commerce Patent and Trademark Office

Atty. Docket No. 520.43279X00 Serial No. 10/706,972 Applicant: YAMASHITA, et al Filing Date: November 14, 2003

Group:

FEB 1 1 2004

U.S. Patent Documents

Examiner Initials	Document No.	Date	Name	Class Subclass	Filing Date If Approp.

Foreign Patent Documents

Document No.	Date	Country	Class Subclass	Translation Yes No
PW EP 0 491 567 A1	6/92	European		
VII 7-50104	2/95	Japan		
/// _9-304127	11/97	Japan		
2000-32732	1/00	Japan		
X WO 00/05849	8/00	PCT/US00/04998		
1 2001-201373	7/01	Japan		
\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	12/01	European		
√X / 2002-39810	2/02	Japan		
XH 2002-135348	5/02	Japan		

Other Documents (including Author, Title, Date, Pertinent Pages, etc.)

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Foreign Patent Documents

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Dupplicated-	7-050104	5/95	-Japan		

Other Documents (including Author, Title, Date, Pertinent Pages, etc.)

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U.S. Patent Documents

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Foreign Patent Documents

	Document No.	Date	Country	Class Subclass	Translation Yes No
XH XH	5-82890 8-082535	11/93 3/96	Japan Japan		(abstract)

Other Documents (including Author, Title, Date, Pertinent Pages, etc.)

Examiner High Vo Date Considered 10/24/04

^{*}Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Information for IDS

I. Prior application:

(i) United States Patent Application

No

(ii) Others

No

NI. Prior Art:

(i)\articles

- 1. * http://www.mita.sd.keio.ac.jp/papers/index.html(down load date:2002.08.01; Proc. Second International Workshop on Structural Health Monitoring, 1999, pp. 56 to 67 corresponds to the content of the URL)
 - * cited by the specification on page 5
- 2. * Nikkei Electronics, Jul. 17, 2002, pp. 37
 - * cited in the specification on page 5
- 3. * IEEE Computer Vuly 2000, pp. 42 to 48
 - * cited in the specification on page 5 .
- 4. * IEEE TRANSACTIONS ON VERY LARGE SCALE INTEGRATION SYSTEMS, VOL. 9, NO. 1, FEBRUARY 2001, pp. 64 to 75
 - * cited in the specification on page 5
- 6. "Illustrated concrete" published by Ohm, pp. 95 to 111 * cited in the specification on page 5
- 7. 99' annual report published by Power Central Research Institute, pp. 92 to 93
 - * cited in the specification on page 5
- 8. http://www.tuat.ac.jp/~masa/study- j.html
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(ii) U. S. P.

No

(iii) Japanese Patent Application

- 1. * Japanese published unexamined patent application No. 2002-38723
 - * cited in the specification on page 4
- 2. * Japanese published unexamined patent application No. Heil1-121766
 - * cited in the specification on page 2

3. * Japanese published unexamined patent application No. 2001-99734

* cited in the specification on page 4

(iv) European Patent Application

No

(v) International Patent Application

No